

Notice of References Cited	Application/Control No. 10/604,276	Applicant(s)/Patent Under Reexamination OLSCHEWSKI, FRANK	
	Examiner CHARLES KIM	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0132401	07-2003	Yamada et al.	250/548
	B	US-			
	C	US-			
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	E	US-			
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FOREIGN PATENT DOCUMENTS

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